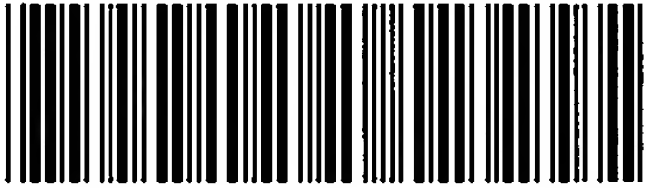


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/633,418	NAKANISHI ET AL.	
	Examiner	Art Unit	
	Tony Chuo	1746	

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Class	Subclass	Date	Examiner
429	161	12/21/2005	TC
(Text search only - see search history printout)			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Name Search	12/21/2005	TC
Talked to Jonathan about possible search.	12/21/2005	TC